

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/721,075	TANAKA, KOICHIRO	
Examiner			Art Unit	1725	Page 1 of 1
M. Alexandra Elve					

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X	C	US-5,953,597	09-1999	Kusumoto et al.	438/161
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	K	US-			
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